# Keysight 86120D and 86122C Multi-Wavelength Meters





## Introduction

The 8612xx family of multi-wavelength meters is known for reliability and durability on the manufacturing floor, on engineer's benches, and even on ships. Statistical data from a large share of the industry's installed wavelength meters enables Keysight to continuously fine-tune its instruments for lower cost of ownership and longer usage. Current updates include an extended recommended recalibration period of two years and a doubled lifetime of the built-in reference laser.

### NEW Fast Update Option for the 86122C Multi-Wavelength Meter

Our flagship model, the Keysight 86122C, is now available with a faster update rate. The new option 86122C-110 accelerates the update rate from 2 per second to 3 per second. The measurement cycle time is reduced from 0.5 seconds to 0.3 seconds. For compatibility, the previous update rate is still available under option 86122C-100.

## NEW 86120D Multi-Wavelength Meter

For the measurement of light sources and signals in the wavelength range from 700 nm to 1700 nm, the new 86120D model offers a compelling set of features with  $\pm 1.5$  ppm accuracy and a measurement cycle time of 0.6 seconds. Like for the 86122C, all wavelength accuracy specifications apply to single-scan measurements - there is no averaging required. This makes them ideal for fast, automated wavelength adjustment procedures.

The 86120D has been qualified for "General Purpose" environmental operating conditions from 0 °C to +55 °C, including shock and vibration levels for use cases that require robust test equipment.

Keysight multi-wavelength meters are Michelson interferometer- based instruments that measure wavelength and optical power of laser light over a specified wavelength range. Simultaneous measurements of multiple laser lines are performed, allowing measurements of DWDM signals and multiple lines of Fabry-Perot lasers. Each laser line is assumed to have a linewidth (including modulation sidebands) of less than:

- 10 GHz for the 86120D, and
- 2.5 GHz for the 86122C

A broadband mode is also available for measuring the weighted center of wider lines.

This technical specifications sheet describes the measurement accuracy and operating conditions of the Keysight 86120D and 86122C Multi-Wavelength Meters. The specifications apply to all functions within the specified environmental conditions. All specifications apply after the instrument's temperature has been stabilized after 15 minutes continuous operation.

#### **Definitions of Terms**

#### Characteristics and specifications

The distinction between specifications and characteristics is described as follows:

- Specifications describe warranted performance.
- Characteristics provide useful, but non-warranted information about the functions and performance of the instrument.
- General Characteristics give additional information for using the instrument. These are general descriptive terms that do not imply a level of performance.

Specifications apply for wavelengths not equal to any water absorption line.

#### Wavelength

- Range refers to the allowable wavelength range of the optical input signal.
- Absolute accuracy indicates the maximum wavelength error over the allowed environmental conditions.
- Differential accuracy indicates the maximum wavelength error in measuring the wavelength difference between two signals that are simultaneously present.
- Minimum resolvable separation indicates the minimum wavelength separation of two laser lines input required to measure each wavelength simultaneously. Two laser lines closer in wavelength than the minimum resolvable separation are not resolved and one average wavelength is displayed.
- Display resolution indicates the minimum incremental change in displayed wavelength.

#### Power

- Calibration accuracy indicates the maximum power calibration error at the specified wavelengths over the allowed environmental conditions.
- Flatness refers to the maximum amplitude error in a measurement between two lines that are separated in wavelength by no more than the specified amount.
- Linearity indicates the maximum power error in measuring the change in power of one laser line.
- Polarization dependence indicates the maximum displayed power variation as the polarization of the input signal is varied.
- Display resolution indicates the minimum incremental change in displayed power.

#### Sensitivity

Sensitivity is defined as the minimum power level of a single laser line input to measure wavelength and power accurately. A laser line with less than the minimum power may be measured but with reduced wavelength and power accuracy. For multiple laser lines input, sensitivity may be limited by total input power.

## Selectivity

Selectivity indicates the ability to measure the wavelength and power of a weak laser line in the proximity of a specified stronger laser line and separated by the specified amount.

#### Input power

- Maximum displayed level indicates the maximum total input power (total of all laser lines present) to accurately measure wavelength and power.
- Maximum safe input power indicates the maximum total input power (total of all laser lines present) to avoid permanent optical damage to the instrument.

#### Maximum number of lines input

Maximum number of lines input is the maximum number of displayed lines. If more than the specified number of lines is input, only the longest wavelength lines are displayed.

#### Input return loss

Input return loss indicates the optical power reflected back to the user's fiber cable relative to the input power. It is limited by the return loss of the front panel connector, and assumes the user's connector is good.

#### Measurement cycle time

Measurement cycle time refers to the cycle time when measuring wavelength and power of laser lines. Specific advanced applications may require longer cycle times.

# Specifications

	86120D	86122C	Notes	
Wavelength				
Range	700 to 1650 nm (182 to 428 THz)	1270 to 1650 nm (182 to 236 THz)	For lines separated by less than or	
Operating range	700 to 1700 nm (176 to 428 THz)		linewidth greater than the specified	
Absolute accuracy			amount, wavelength accuracy is	
	± 1.5 ppm	± 0.2 ppm (within 15°C to 35°C)	reduced. For laser lines separated	
	typ. $\pm$ 1 ppm (within 15 °C to 35 °C)		by ≥ 10 GHz (≥ 20 GHz for 86120D)	
At 1550 nm	± 2.3 pm	± 0.3 pm	and linewidths ≤ 2.5 GHz (≤ 10 GHz	
At 1310 nm	± 2.1 pm	± 0.3 pm	for 86120D).	
Differential accuracy 1	± 0.4 ppm	± 0.15 ppm		
Minimum resolvable separ	ration <sup>1</sup> (equal power lines input)			
	15 GHz	5 GHz		
At 1550 nm	0.12 nm	0.04 nm		
At 1310 nm	0.09 nm	0.03 nm		
Display resolution				
	0.0001 nm			
Units	nm (vacuum or standard air), cm <sup>-1</sup> , THz			
Power				
Calibration accuracy 5	± 0.6 dB	± 0.5 dB		
	(at $\pm$ 30 nm from 780 nm $^{1}$ , 1310 nm,	(at $\pm$ 30 nm from 1310 nm		
	and 1550 nm)	and 1550 nm)		
Flatness <sup>1</sup>	± 0.2 dB (1200 to 1600 nm)	± 0.2 dB (1270 to 1600 nm)	30 nm from any wavelength	
	± 0.5 dB (700 to 1650 nm)	± 0.5 dB (1270 to 1650 nm)		
Linearity	± 0.3 dB (1200 to 1600 nm)	± 0.3 dB (1270 to 1600 nm)	Lines above -30 dBm	
Polarization dependence	± 0.6 dB(1200 to 1600 nm)	± 0.6 dB (1270 to 1600 nm)		
	± 1.5 dB <sup>1</sup> (700 to 1650 nm)	± 1.0 dB <sup>1</sup> (1600 to 1650 nm)		
Display resolution	0.01 dB			
Units	dBm, mW, μW			
Sensitivity				
Single line input	-20 dBm (700 to 900 nm)	NA	Single measurement, without	
	-25 dBm <sup>1</sup> (800 to 1200 nm)	NA	averaging	
	-40 dBm <sup>6</sup> (1200 to 1600 nm)	-32 dBm (1270 to 1600 nm)		
	-30 dBm <sup>6</sup> (1600 to 1650 nm)	-22 dBm (1600 to 1650 nm)		
Multiple lines input <sup>1</sup>	30 dB below total input power, but not less than single line input sensitivity			
Selectivity <sup>1</sup>	25 dB spacing ≥ 100 GHz	25 dB spacing ≥ 90 GHz		
	10 dB spacing ≥ 25 GHz	10 dB spacing ≥ 10 GHz		

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Number of laser lines may be limited by signal power requirements for accurate wavelength measurements. Type tested means tested, but not warranted, for continuous operation.

At 1550 nm.

<sup>5.</sup> Excluding polarization effects.6. Spurious free under Preset conditions.

# Specifications (continued)

	86120D	86122C	Notes	
Input power				
Maximum displayed level	+10 dBm	+10 dBm	- Sum of all lines input	
Maximum safe input level	+18 dBm	+18 dBm	· Sum of all lines input	
Return loss				
<ul> <li>With non-angled (PC) connectors (Option 021)</li> </ul>	35 dB	35 dB		
- With angled (APC) connectors (Option 022)	50 dB	50 dB	For wavelengths above 1200 nm	
Measurement cycle time	0.6 s	0.5 s (86122C-100)		
		0.3 s (86122C-110)		
Maximum number of lines	1000 <sup>2</sup>	1000 <sup>2</sup>		
Measurement modes	List by wavelength table, list by and power, average wavelength	power table, signal wavelength and total power	Data logging and sorting by any parameter are included	
Delta modes	Delta wavelength, delta power,	delta wavelength and power		
Built in automatic measurement applications		Ŭ ,		
Signal to noise ratio 1,4,7				
Channel spacing				
– ≥ 200 GHz	> 35 dB with 100 averages		- 0.1 nm noise bandwidth,	
– ≥ 100 GHz	> 35 dR with IIII averages		- lines above –25 dBm	
– ≥ 50 GHz		> 27 dB with 100 averages	tilles above -25 ubili	
Drift				
	Maximum, minimum, total drift	(max-min) of wavelengths and po	owers over time	
Fabry-Perot characterization				
	Mean wavelength, peak wavele power, sigma	ngth, mode spacing, full-width h	alf maximum, peak amplitude, total	
Additional features				
		r off), user adjustable peak excur length limits, graphical display, s	sion and peak threshold, user ave and recall instrument states.	
Inputs/outputs				
Optical input	9 μm/125 μm single-mode fibe			
Rear panel connectors	LAN, PS/2 for keyboard and momonitor, GPIB, USB, AC Line	ouse, SVGA and DVI for external		

- Number of laser lines may be limited by signal power requirements for accurate wavelength measurements. Type tested means tested, but not warranted, for continuous operation.
- At 1550 nm.
- Excluding polarization effects.
- Spurious free under Preset conditions. For laser lines separated by  $\geq$  10 GHz ( $\geq$  20 GHz for 86120D) and linewidths  $\leq$  2.5 GHz ( $\leq$  10 GHz for 86120D).

# Specifications (continued)

	86120D	86122C	Notes
Reliability			
Recommended re-calibration	2 years	2 years	
Environmental			
Operational			
Temperature	0 to +55 °C	15 to 35 °C	
Humidity <sup>1</sup>	< 95% R.H. at +40 °C	< 75% R.H. at 35 °C Indoor use only	
Storage			
Temperature	-40 °C to +70 °C	-40 °C to +70 °C	
Humidity <sup>1</sup>	< 90% R.H. at +65 °C for 24 hrs.	< 95% R.H. at +40 °C for 5 day cycle	Non-condensing
Dimensions and weight			
Dimensions (H x W x D)	138 mm x 42	5 mm x 520 mm	
	(5.2 in x 16.7 in x 20.5 in)		
	14.5	kg (32 lb)	
Power requirements			
Voltage and frequency	100 V / 115 V / 230 V / 240 V~, 50 Hz / 60 Hz		
Maximum power	310 VA max		

<sup>1.</sup> Type tested means tested, but not warranted, for continuous operation.

## General Characteristics

The 8612x wavelength meters contain HeNe reference lasers, which have limited operating lifetimes, like all gas-discharge lasers. With the latest enhancement of the reference lasers used in the new 86122C, the average laser lifetime has doubled. The 2-year recommended re-calibration period helps minimize planned and unplanned downtimes and cost of ownership.

## Ordering Information

For the most up-to-date ordering information, please contact your Keysight sales representative.

86120D Multi-w	vavelength meter
Optical connect	ors
86120D-021	Straight (non-angled) connector interface-PC
86120D-022	Angled contact interface-APC
Accessories	
86122A-1CM	Rack mount kit without handles
86122A-1CN	Handle kit
86122A-1CP	Rack mount kit plus handles
86120D-UK6	Commercial calibration certificate with test data
Calibration	
R-50C-011-3	Calibration Assurance Plan - Return to Keysight - 3 years
R-50C-011-5	Calibration Assurance Plan – Return to Keysight – 5 years
R-50C-021-3	ANSI Z540-1-1994 Calibration – 3 years
R-50C-021-5	ANSI Z540-1-1994 Calibration – 5 years

# Ordering Information (continued)

For the most up-to-date ordering information, please contact your Keysight sales representative.

Connector interf	aces (order separately)
81000FI	FC connector interface (FC/PC)
81000HI	E-2000 connector interface
81000KI	SC connector interface
81000LI	LC connector interface
81000MI	MU connector interface
81000NI	FC connector interface (FC/APC with narrow key)
81000SI	DIN connector interface
81000VI	ST connector interface
86122C Multi-wa	avelength meter
86122C-100	Wavelengths 1270 nm to 1650 nm, ± 0.2 ppm
86122C-110	Wavelengths 1270 nm to 1650 nm, Fast Update, ± 0.2 ppm
Optical connect	ors
86122C-021	Straight (non-angled) connector interface-PC
86122C-022	Angled contact interface-APC
Accessories	
86122A-1CM	Rack mount kit without handles
86122A-1CN	Handle kit
86122A-1CP	Rack mount kit plus handles
86122C-UK6	Commercial calibration certificate with test data
Calibration	
R-50C-011-3	Calibration Assurance Plan – Return to Keysight – 3 years
R-50C-011-5	Calibration Assurance Plan – Return to Keysight – 5 years
R-50C-021-3	ANSI Z540-1-1994 Calibration – 3 years
R-50C-021-5	ANSI Z540-1-1994 Calibration – 5 years

CLASS 1 LASER PRODUCT (IEC 60825-1)

## Optical Instruments Online Information

Optical test instruments	www.keysight.com/find/oct
Lightwave component analyzers	www.keysight.com/find/lca
Polarization solutions	www.keysight.com/find/pol
Spectral analysis products	www.keysight.com/find/mwm
Electro-optical converters	www.keysight.com/find/ref
Optical test instruments accessories	www.keysight.com/find/octaccessories
Firmware and driver download	www.keysight.com/find/octfirmware
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